

# HIGH-RESOLUTION SOFT X-RAY MEASUREMENTS IN 2.3keV/u $^{15}\text{N}^{7+}$ IONS TRANSMITTED THROUGH A MICROCAPILLARY

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When a slow highly charged ion approaches a solid surface, it resonantly captures electrons from the solid valence band into an excited state of the ion. X-rays emitted from 2.3keV/u  $^{15}\text{N}^{7+}$  ions transmitted through a thin Ni microcapillary target were measured with a high-resolution soft X-ray spectrometer<sup>1,2)</sup>. The target was  $\sim 1\text{mm}^2$  in area with a thickness of  $\sim 1\ \mu\text{m}$  and had a multitude of straight holes  $\sim 200\text{nm}$  in diameter<sup>1)</sup>. The spectrometer consists of an entrance slit, a concave grating and a back-illuminated CCD<sup>2)</sup>. The energy resolution and the energy accuracy were 3.1eV (FWHM) at 500eV and 0.5eV at 500eV, respectively. The time window was 37ps for a slit width of 25  $\mu\text{m}$  and 2.3 keV/u ions. The present experiment was performed using 14.5GHz Caprice-type electron cyclotron resonance (ECR) ion source at RIKEN<sup>3)</sup>.

X-ray spectra were observed at the downstream surface of the target ( $T=0\text{ns}$ ), 0.35mm downstream ( $T=0.52\text{ns}$ ), and 2.75mm downstream ( $T=4.10\text{ns}$ ). Figure 1 shows the spectrum with four peaks at the target immediately downstream. Five peaks were observed, at  $625.1 \pm 0.7\text{eV}$ ,  $593.0 \pm 0.7\text{eV}$ ,  $500.3 \pm 0.5\text{eV}$ ,  $430.5 \pm 0.4\text{eV}$ , and  $425.8 \pm 0.4\text{eV}$ . According to reference data, the five peaks are attributed to core electronic transitions of H-like<sup>4)</sup>  $4p\ ^2P_{3/2} \rightarrow 1s\ ^2S_{1/2}$  (625.3eV),  $3p\ ^2P_{3/2} \rightarrow 1s\ ^2S_{1/2}$  (592.9eV),  $2p\ ^2P_{3/2, 1/2} \rightarrow 1s\ ^2S_{1/2}$  (500.3eV, 500.2eV), He-like<sup>5)</sup>  $1s2p\ ^1P_1 \rightarrow 1s^2\ ^1S_0$  (430.7eV), and  $1s2p\ ^3P_1 \rightarrow 1s^2\ ^1S_0$  (426.3eV). The observed transitions with their core configurations are summarized in Table 1.

Figure 2 shows the X-ray intensities for transitions from  $2p\ ^2P_{3/2, 1/2}$ ,  $1s2p\ ^1P_1$ , and  $^3P_1$  states as a function of the time after the ion leaves the microcapillary target. This result provides information on the decay process related to outer shells.

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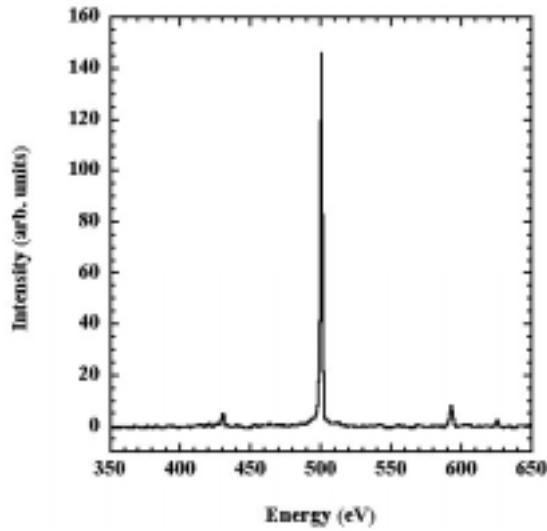


Fig. 1. Spectrum of  $K$  X-rays measured with the spectrometer immediately downstream of the target ( $T=0$ ns), for  $2.3\text{keV/u } ^{15}\text{N}^{7+}$  ions transmitted through a Ni microcapillary. The spectrum has four peaks, at  $625.1 \pm 0.7\text{eV}$ ,  $593.0 \pm 0.7\text{eV}$ ,  $500.3 \pm 0.5\text{eV}$ , and  $430.5 \pm 0.4\text{eV}$ .

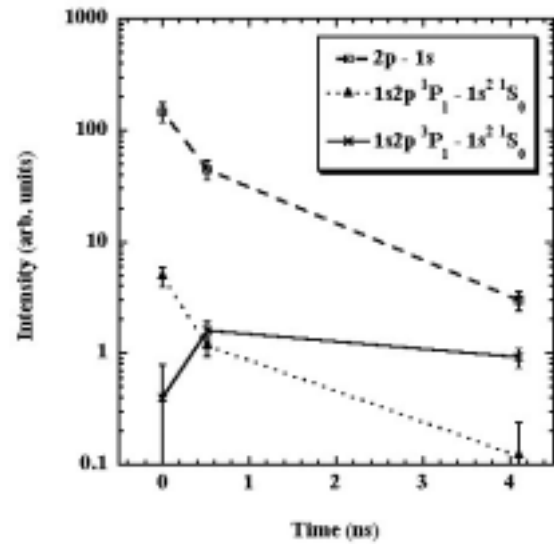


Fig. 2. X-ray decays of the  $2p \ ^2P_{3/2, 1/2}$ ,  $1s2p \ ^1P_1$ , and  $^3P_1$ . The error bars, except for the  $^3P$  first and  $^1P$  last points, are mainly due to the beam stability

Table 1. Electronic core configurations.

Experiment	Ref. data	Core configuration	Term
$625.1 \pm 0.7\text{eV}$	$625.3\text{eV}^{(4)}$	$4p \rightarrow 1s$	$^2P_{3/2} \rightarrow ^2S_{1/2}$
$593.0 \pm 0.7\text{eV}$	$592.9\text{eV}^{(4)}$	$3p \rightarrow 1s$	$^2P_{3/2} \rightarrow ^2S_{1/2}$
$500.3 \pm 0.5\text{eV}$	$500.3\text{eV}^{(4)}$ $500.2\text{eV}^{(4)}$	$2p \rightarrow 1s$	$^2P_{3/2} \rightarrow ^2S_{1/2}$ $^2P_{1/2} \rightarrow ^2S_{1/2}$
$430.5 \pm 0.4\text{eV}$	$430.7\text{eV}^{(5)}$	$1s2p \rightarrow 1s^2$	$^1P_1 \rightarrow ^1S_0$
$425.8 \pm 0.4\text{eV}$	$426.3\text{eV}^{(5)}$	$1s2p \rightarrow 1s^2$	$^3P_1 \rightarrow ^1S_0$

## References

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